

<b>PCN Number:</b>	20140212002			<b>PCN Date:</b>	02/17/2014						
<b>Title:</b>	Qualification of copper wire as alternate bonding material for selected products in VSSOP Package										
<b>Customer Contact:</b>	<a href="#">PCN Manager</a>	<b>Phone:</b>	+1(214)480-6037	<b>Dept:</b>	Quality Services						
<b>Proposed 1<sup>st</sup> Ship Date:</b>	03/17/2014	<b>Estimated Sample Availability:</b>	02/17/2014								
<b>Change Type:</b>											
<input type="checkbox"/>	Assembly Site	<input checked="" type="checkbox"/>	Assembly Process	<input checked="" type="checkbox"/>	Assembly Materials						
<input type="checkbox"/>	Design	<input type="checkbox"/>	Electrical Specification	<input type="checkbox"/>	Mechanical Specification						
<input type="checkbox"/>	Test Site	<input type="checkbox"/>	Packing/Shipping/Labeling	<input type="checkbox"/>	Test Process						
<input type="checkbox"/>	Wafer Bump Site	<input type="checkbox"/>	Wafer Bump Material	<input type="checkbox"/>	Wafer Bump Process						
<input type="checkbox"/>	Wafer Fab Site	<input type="checkbox"/>	Wafer Fab Materials	<input type="checkbox"/>	Wafer Fab Process						
<input type="checkbox"/>		<input type="checkbox"/>	Part Number Change								
<b>PCN Details</b>											
<b>Description of Change:</b>											
To qualify Cu wire as alternative bond material for selected products in VSSOP package. Most of the devices in this notification were included in Forecast PCN20125301A published on July 31, 2012 which was issued from the National Semiconductor PCN system.											
<table border="1" style="width: 100%;"> <thead> <tr> <th style="width: 25%;"></th> <th style="width: 25%; text-align: center;">From</th> <th style="width: 50%; text-align: center;">To</th> </tr> </thead> <tbody> <tr> <td><b>Wire</b></td> <td style="text-align: center;">Au, 0.9mil &amp; 1.0mil</td> <td style="text-align: center;">Cu, 1 mil or Au, 0.9mil &amp; 1.0mil</td> </tr> </tbody> </table>							From	To	<b>Wire</b>	Au, 0.9mil & 1.0mil	Cu, 1 mil or Au, 0.9mil & 1.0mil
	From	To									
<b>Wire</b>	Au, 0.9mil & 1.0mil	Cu, 1 mil or Au, 0.9mil & 1.0mil									
<b>Reason for Change:</b>											
<p>Continuity of supply.</p> <p>1) To align with world technology trends and use wiring with enhanced mechanical and electrical properties</p> <p>2) Maximize flexibility within our Assembly/Test production sites.</p> <p>3) Cu is easier to obtain and stock</p>											
<b>Anticipated impact on Fit, Form, Function, Quality or Reliability (positive / negative):</b>											
None											
<b>Changes to product identification resulting from this PCN:</b>											
None											
<b>Product Affected:</b>											
LM7322MM/NOPB	LM8262MM/J7001401	LM8272MM	LMC6035IMM								
LM7322MME/NOPB	LM8262MM/J7001401	LM8272MM/NOPB	LMC6482IMM								
LM7322MMX/NOPB	LM8262MM/NOPB	LM8272MMX/NOPB	LMC6482IMMX								
LM7332MM/NOPB	LM8262MMX/J7001402	LMC555CMM	LMC6772AIMM								
LM7332MME/NOPB	LM8262MMX/J7001402	LMC555CMM/NOPB	LMC8101MM								
LM7332MMX/NOPB	LM8262MMX/NOPB	LMC555CMMX	LMC8101MM/NOPB								
LM8262MM											

**Qualification Data: Approved November, 2013**

This qualification has been specifically developed for the validation of this change. The qualification data validates that the proposed change meets the applicable released technical specifications.

**Qualification Device: LMC6482IMM/NOPB (MSL 1-260c)**

**Package Construction Details**

Assembly Site:	TIEM	Mold Compound:	4209002
# Pins-Designator, Family:	8-DGK, VSSOP	Mount Compound:	8080598
Leadframe (Finish, Base):	Matte Sn, Cu	Bond Wire:	1 Mil Dia., Cu

**Qualification:**     Plan     **Test Results**

Reliability Test	Conditions	Sample Size / Fail		
		Lot 1	Lot 2	Lot 3
**Autoclave 121C	121C, 2 ATM (96 hrs)	77/0	77/0	77/0
**T/C -65C/150C	-65C/+150C (500 Cyc)	77/0	77/0	77/0

Notes: \*\*Tests received preconditioning sequence: MSL1-260C

**Reference Qualification Data: Approved October, 2012**

This qualification has been specifically developed for the validation of this change. The qualification data validates that the proposed change meets the applicable released technical specifications.

**Qualification Device: LMC6482AIM/NOPB (MSL 1-260c)**

**Package Construction Details**

Assembly Site:	TIEM	Mold Compound:	4209002
# Pins-Designator, Family:	8-D, SOIC	Mount Compound:	8080598
Leadframe (Finish, Base):	Matte Sn, Cu	Bond Wire:	1 Mil Dia., Cu

**Qualification:**     Plan     **Test Results**

Reliability Test	Conditions	Sample Size / Fail		
		Lot 1	Lot 2	Lot 3
**Biased HAST	130C/85%RH (96 Hrs)	77/0	77/0	77/0
**Autoclave 121C	121C, 2 ATM (96 hrs)	77/0	77/0	77/0
**T/C -65C/150C	-65C/+150C (500 Cyc)	77/0	77/0	77/0

Notes: \*\*Tests received preconditioning sequence: MSL1-260C

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

<b>Location</b>	<b>E-Mail</b>
USA	<a href="mailto:PCNAmericasContact@list.ti.com">PCNAmericasContact@list.ti.com</a>
Europe	<a href="mailto:PCNEuropeContact@list.ti.com">PCNEuropeContact@list.ti.com</a>
Asia Pacific	<a href="mailto:PCNAsiaContact@list.ti.com">PCNAsiaContact@list.ti.com</a>
Japan	<a href="mailto:PCNJapanContact@list.ti.com">PCNJapanContact@list.ti.com</a>